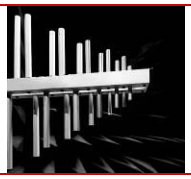
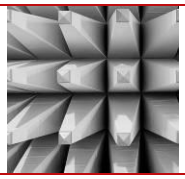




CETECOM™
CETECOM ICT Services
consulting - testing - certification

TEST REPORT

Test report no.: 1-6965/13-16-05

DAkkS Deutsche Akkreditierungsstelle D-PL-12076-01-01

Testing laboratory

CETECOM ICT Services GmbH
Untertuerkheimer Strasse 6 – 10
66117 Saarbruecken / Germany
Phone: + 49 681 5 98 - 0
Fax: + 49 681 5 98 - 9075
Internet: http://www.cetecom.com
e-mail: ict@cetecom.com

Accredited Testing Laboratory:
The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the Deutsche Akkreditierungsstelle GmbH (DAkkS)
The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with the registration number: D-PL-12076-01-01
Area of Testing:
Radio Communications & EMC (RCE)

Applicant

Sony Mobile Communications AB
Nya Vattentornet
22188 Lund / SWEDEN
Phone: +46 46 19 30 00
Fax: -/-
Contact: Mikael Nilsson
e-mail: Micke.nilsson@sonymobile.com
Phone: +46 7 03 22 75 03

Manufacturer

Sony Mobile Communications AB
Nya Vattentornet
22188 Lund / SWEDEN

Test standard/s

47 CFR Part 27	Title 47 of the Code of Federal Regulations; Chapter I; Part 27 - Miscellaneous wireless communications services

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item:	**Smart Phone GPRS/EGPRS 850/900/1800/1900; UMTS HSPA FDDI/II/V; LTE FDD1/3/17/18; LTE TDD41; CDMA 2K BC0/BC6; WLAN b/g/n/a/ac; BT 4.0; RFID; A-GPS**
FCC ID:	**PY7PM-0750**
Frequency:	LTE FDD 17: 704 MHz to 716 MHz
Technology tested:	LTE FDD
Antenna:	Integrated antenna
Power supply:	3.7 V DC by Li - polymer battery
Temperature range:	-30°C to +60°C

This test report is electronically signed and valid without handwriting signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

Test report authorised:

cn=Stefan Boes, o=CETECOM ICT Services GmbH, ou=BOE-111011, email=Stefan.Boes@cetecom.com, c=DE
2014.02.28 08:17:47 +01'00'

Stefan Bös
Senior Testing Manager

Test performed:

p.o.

cn=David Lang, o=CETECOM ICT Services GmbH, ou=LNG-131017, email=david.lang@cetecom.com, c=DE
2014.02.28 11:03:30 +01'00'

Marco Bertolino
Testing Manager

1 Table of contents

2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CETECOM ICT Services GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.
The test report may only be reproduced or published in full. Reproduction or publication of extracts from the report requires the prior written approval of CETECOM ICT Services GmbH.
The testing service provided by CETECOM ICT Services GmbH has been rendered under the current "General Terms and Conditions for CETECOM ICT Services GmbH".
CETECOM ICT Services GmbH will not be liable for any loss or damage resulting from false, inaccurate, inappropriate or incomplete product information provided by the customer.
Under no circumstances does the CETECOM ICT Services GmbH test report include any endorsement or warranty regarding the functionality, quality or performance of any other product or service provided.
Under no circumstances does the CETECOM ICT Services GmbH test report include or imply any product or service warranties from CETECOM ICT Services GmbH, including, without limitation, any implied warranties of merchantability, fitness for purpose, or non-infringement, all of which are expressly disclaimed by CETECOM ICT Services GmbH.
All rights and remedies regarding vendor's products and services for which CETECOM ICT Services GmbH has prepared this test report shall be provided by the party offering such products or services and not by CETECOM ICT Services GmbH.
In no case this test report can be considered as a Letter of Approval.

This test report is electronically signed and valid without handwritten signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

2.2 Application details

Date of receipt of order:	2014-02-19
Date of receipt of test item:	2014-02-17
Start of test:	2014-02-17
End of test:	2014-02-27
Person(s) present during the test:	-/-

3 Test standard/s

Test standard	Date	Test standard description
47 CFR Part 27		Title 47 of the Code of Federal Regulations; Chapter I; Part 27 - Miscellaneous wireless communications services

4 Test environment

Temperature:	T_{nom}	+22 °C	during room temperature tests
	T_{max}	+60 °C	during high temperature tests
	T_{min}	-30 °C	during low temperature tests
Relative humidity content:		42 %	
Barometric pressure:		not relevant for this kind of testing	
Power supply:	V_{nom}	3.7 V	DC by Li - polymer battery
	V_{max}	4.4 V	
	V_{min}	3.3 V	

5 Test item

Kind of test item	**:**	**Smart Phone GPRS/EGPRS 850/900/1800/1900; UMTS HSPA FDDI/II/V; LTE FDD1/3/17/18; LTE TDD41; CDMA 2K BC0/BC6; WLAN b/g/n/a/ac; BT 4.0; RFID; A-GPS**
S/N serial number	**:**	**Radiated units: CB5126D71H; CB5126D721** **Conducted units: CB5126DAXC; CB5126DB0L**
HW hardware status	**:**	**AP1.0**
SW software status	**:**	**17.1.C.0.127**
Frequency band [MHz]	**:**	**LTE FDD 17: 704 MHz to 716 MHz**
Type of modulation	**:**	**QPSK, 16-QAM**
Antenna	**:**	**Integrated antenna**
Power supply	**:**	**3.7 V DC by Li - polymer battery**
Temperature range	**:**	**-30°C to +60 °C**

5.1 Additional information

Test setup- and EUT-photos are included in test report: 1-6965/13-16-01_AnnexA
1-6965/13-16-01_AnnexB
1-6965/13-16-01_AnnexC

6 Test laboratories sub-contracted

None

7 Summary of measurement results

☒	No deviations from the technical specifications were ascertained
☐	There were deviations from the technical specifications ascertained

TC identifier	Description	verdict	date	Remark
RF-Testing	CFR Part 27	passed	2014-02-28	-/-

7.1 LTE – Band 17

Test Case	temperature conditions	power source voltages	Pass	Fail	NA	NP	Remark
RF Output Power	Nominal	Nominal	☒	☐	☐	☐	-/-
Frequency Stability	Nominal	Nominal	☒	☐	☐	☐	-/-
Spurious Emissions Radiated	Nominal	Nominal	☒	☐	☐	☐	-/-
Spurious Emissions Conducted	Nominal	Nominal	☒	☐	☐	☐	-/-
Block Edge Compliance	Nominal	Nominal	☒	☐	☐	☐	-/-
Occupied Bandwidth	Nominal	Nominal	☒	☐	☐	☐	-/-

Note: NA = Not applicable; NP = Not performed

8 RF measurements

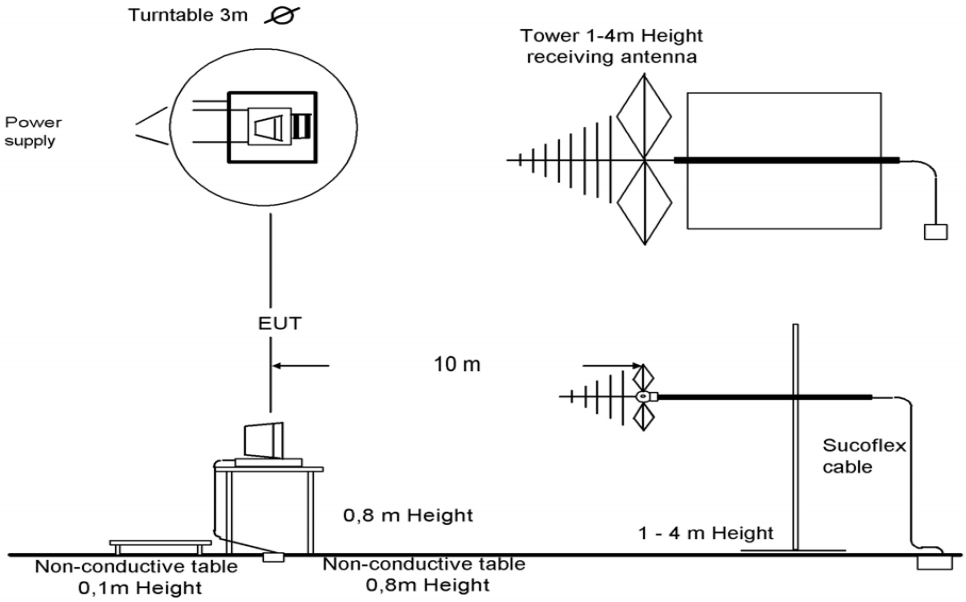
8.1 Description of test setup

For the spurious measurements we use the substitution method according TIA/EIA 603.

8.1.1 Radiated measurements

The radiated emissions from the EUT are performed in a semi anechoic chamber. The EUT is placed on a conductive turntable and powered with nominal voltage. The signalling is performed either from outside the chamber with a signalling unit (AP or other) by air link using a signalling antenna or directly by special test software from the customer.

Semi anechoic chamber

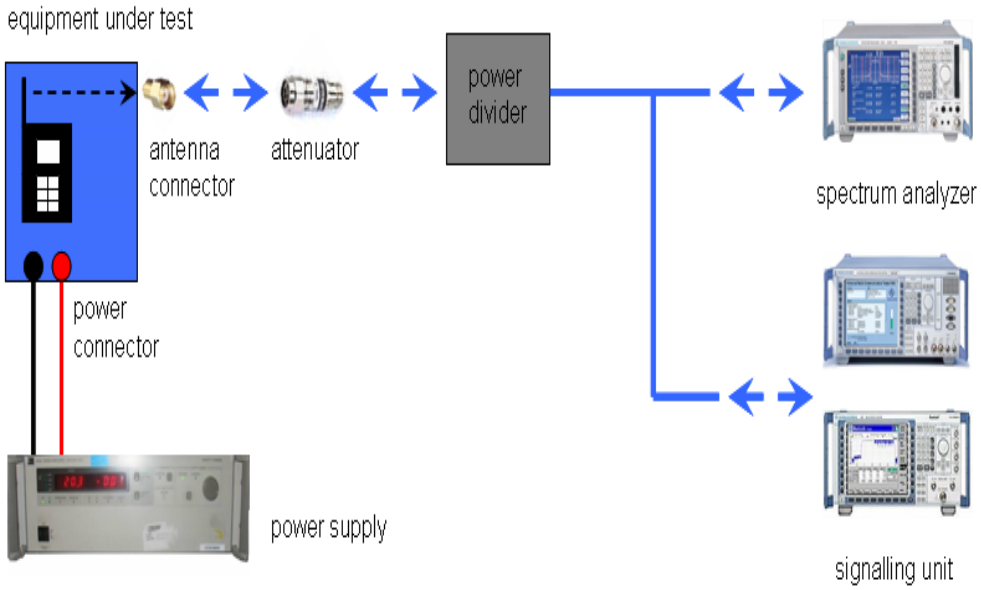


Picture 1: Diagram radiated measurements

9 kHz - 30 MHz:	active loop antenna
30 MHz – 1 GHz:	tri-log antenna
> 1 GHz:	horn antenna

8.1.2 Conducted measurements

The EUT's RF signal is coupled out by the antenna connector which is supplied by the manufacturer. The signal is first 10dB attenuated before it is power divided (~6dB loss per branch). One of the signal paths is connected to the signalling unit (AP or other), the other one is connected to the spectrum analyzer. The specific losses for both signal paths are first checked within a calibration. The measurement readings on the signalling unit/spectrum analyzer are corrected by the specific test set-up loss. The attenuator, power divider, signalling unit and the spectrum analyzer are impedance matched on 50 Ohm. If special software is used, there is no power divider necessary.



Picture 2: Diagram conducted measurements

The term measuring receiver refers to either a selective voltmeter or a spectrum analyser.

Frequency being measured f	Measuring receiver bandwidth 6 dB	Spectrum analyser bandwidth 3dB
f < 150 kHz	200 Hz or	300 Hz
150 kHz ≤ f < 25 MHz	9 kHz or	10 kHz
25 MHz ≤ f < 1000 MHz	120 kHz or	100 kHz
1000 MHz ≤ f		1 MHz
NOTE: Specific requirements in CEPT/ERC/Recommendation 70-03 [2] shall be applied where applicable.		

8.2 LTE technologies supported by EUT

Channel bandwidth

	Band 4	Band 7	Band 13	Band 17
[MHz]				
1.4	☐	☐	☐	☐
3	☐	☐	☐	☐
5	☐	☐	☐	☒
10	☐	☐	☐	☒
15	☐	☐	☐	☐
20	☐	☐	☐	☐

8.3 Results LTE – Band 17

The EUT was set to transmit the maximum power.

8.3.1 RF output power

Description:

This paragraph contains average power, peak output power and EIRP measurements for the mobile station. In all cases, the peak output power is within the required mask (this mask is specified in the JTC standards, TIA PN3389 Vol. 1 Chap 7, and is no FCC requirement).

Measurement:

The mobile was set up for the maximum output power with pseudo random data modulation.

To determine the Peak-To-Average Power Ratio (PAPR) the measurement was performed with the Power Complementary Cumulative Distribution Function (CCDF).

Measurement parameters	
Detector:	Peak and RMS (Power in Burst)
Sweep time:	Auto
Video bandwidth:	Depends on Channel Bandwidth
Resolution bandwidth:	Depends on Channel Bandwidth
Span:	Zero Span
Trace-Mode:	Max Hold

Limits:

FCC
34.77 dBm
Nominal Peak Output Power
In measuring transmissions in this band using an average power technique, the peak-to-average ratio (PAR) of the transmission may not exceed 13 dB.

Results:

Output Power (conducted)						
Bandwidth (MHz)	**Frequency (MHz)**	**Resource block allocation**	**Average Output Power (dBm) QPSK**	**Peak to Average Ratio (dB)**	**Average Output Power (dBm) 16-QAM**	**Peak to Average Ratio (dB)**
5	706.5	1 RB low	23.5	4.2	22.5	5.2
		1 RB high	23.6	4.4	22.4	5.3
		50% RB mid	22.4	4.9	21.5	5.8
		100% RB	22.4	5.6	21.4	6.5
	710.0	1 RB low	23.4	4.9	22.8	4.3
		1 RB high	23.5	4.9	22.9	4.6
		50% RB mid	22.5	5.7	21.4	5.0
		100% RB	22.4	6.6	21.4	5.5
	713.5	1 RB low	23.6	4.4	22.4	5.6
		1 RB high	23.6	4.5	22.4	5.6
		50% RB mid	22.5	5.0	21.5	5.8
		100% RB	22.5	5.6	21.5	6.3
10	709.0	1 RB low	23.5	5.1	22.6	4.3
		1 RB high	23.6	5.3	22.7	4.6
		50% RB mid	22.5	5.8	21.4	5.1
		100% RB	22.4	6.5	21.4	5.7
	710.0	1 RB low	23.4	4.3	22.3	5.4
		1 RB high	23.6	4.7	22.3	5.6
		50% RB mid	22.5	5.0	21.5	5.8
		100% RB	22.4	5.8	21.4	6.4
	711.0	1 RB low	23.5	5.5	22.3	4.2
		1 RB high	23.6	5.7	22.4	4.5
		50% RB mid	22.4	5.9	21.4	5.1
		100% RB	22.5	6.1	21.4	5.2
Measurement uncertainty			± 0.5 dB			

The output power is measured with full resource blocks.

Output Power (radiated)			
Bandwidth (MHz)	**Frequency (MHz)**	**Average Output Power (dBm) QPSK**	**Average Output Power (dBm) 16-QAM**
5	706.5	19.0	17.9
	710.0	19.9	19.3
	713.5	19.8	18.6
10	709.0	19.0	18.1
	710.0	20.0	18.7
	711.0	19.8	18.6
Measurement uncertainty		± 3.0 dB	

Result: **Passed**

8.3.2 Frequency stability

Description:

In order to measure the carrier frequency under the condition of AFC lock, it is necessary to make measurements with the mobile station in a “call mode”. This is accomplished with the use of a R&S CMW500 DIGITAL RADIOCOMMUNICATION TESTER.
1. Measure the carrier frequency at room temperature.
2. Subject the mobile station to overnight soak at -30 C.
3. With the mobile station, powered with V_{nom}, connected to the CMW500 and in a simulated call on channel 1412 (centre channel), measure the carrier frequency. These measurements should be made within two minutes of powering up the mobile station, to prevent significant self warming.
4. Repeat the above measurements at 10°C increments from -30°C to +60°C. Allow at least 1.5 hours at each temperature, unpowered, before making measurements.
5. Remeasure carrier frequency at room temperature with V_{nom}. Vary supply voltage from V_{min} to V_{max}, in 0.1 Volt steps remeasuring carrier frequency at each voltage. Pause at V_{nom} for 1.5 hours unpowered, to allow any self heating to stabilize, before continuing.
6. At all temperature levels hold the temperature to +/- 0.5°C during the measurement procedure.

This measurement was performed with the highest channel bandwidth supported from the EUT on the middle channel

Measurement:

Measurement parameters	
Detector:	Measured with CMW500
Sweep time:	
Video bandwidth:	
Resolution bandwidth:	
Span:	
Trace-Mode:	

Limits:

FCC
Frequency Stability
< 2.5 ppm

Results:

FREQ ERROR versus VOLTAGE

Voltage (V)	Frequency Error (Hz)	Frequency Error (%)	Frequency Error (ppm)
3.3	12	0.00000169	0.0169
3.4	-9	-0.00000127	-0.0127
3.5	11	0.00000155	0.0155
3.6	7	0.00000099	0.0099
3.7	10	0.00000141	0.0141
3.8	8	0.00000113	0.0113
3.9	-13	-0.00000183	-0.0183
4.0	1	0.00000014	0.0014
4.1	-14	-0.00000197	-0.0197
4.2	13	0.00000183	0.0183
4.3	8	0.00000113	0.0113
4.4	3	0.00000042	0.0042

FREQ ERROR versus TEMPERATURE

Temperature (°C)	Frequency Error (Hz)	Frequency Error (%)	Frequency Error (ppm)
-30	-7	-0.00000099	-0.0099
-20	-3	-0.00000042	-0.0042
-10	2	0.00000028	0.0028
± 0	-15	-0.00000211	-0.0211
10	9	0.00000127	0.0127
20	-2	-0.00000028	-0.0028
30	-15	-0.00000211	-0.0211
40	1	0.00000014	0.0014
50	-1	-0.00000014	-0.0014
60	-14	-0.00000197	-0.0197

Result: **Passed**

8.3.3 Spurious emissions radiated

Description:

The following steps outline the procedure used to measure the radiated emissions from the mobile station. The site is constructed in accordance with ANSI C63.4:2009 requirements and is recognized by the FCC to be in compliance for a 3 and a 10 meter site. The spectrum was scanned from 30 MHz to the 10th harmonic of the highest frequency generated within the equipment, which is the transmitted carrier that can be as high as 746 MHz. Measurement is made up to 12.75 GHz. The resolution bandwidth is set as outlined in Part 27.53. The spectrum was scanned with the mobile station transmitting at carrier frequencies that pertain to low, mid and high channels of the LTE band 17.

The final open field emission (here 10m semi-anechoic chamber listed by FCC) test procedure is as follows:

a) The test item was placed on a 0.8 meter high non-conductive stand at a 3 meter test distance from the receive antenna.
b) The antenna output was terminated in a 50 ohm load (if possible).
c) A double ridged wave guide antenna was placed on an adjustable height antenna mast 3 meters from the test item for emission measurements.
d) Detected emissions were maximized at each frequency by rotating the test item and adjusting the receive antenna height and polarization. The maximum meter reading was recorded. The radiated emission measurements of the harmonics of the transmit frequency through the 10th harmonic were measured with peak detector and 1 MHz bandwidth. If the harmonic could not be detected above the noise floor, the ambient level was recorded. The equivalent power into a dipole antenna was calculated from the field intensity levels measured at 3 meters.
e) Now each detected emissions were substituted by the substitution method, in accordance with the TIA/EIA 603.

Measurement:

Measurement parameters	
Detector:	Peak
Sweep time:	2 s
Video bandwidth:	Below 1 GHz: 100 kHz Above 1 GHz: 1 MHz
Resolution bandwidth:	Below 1 GHz: 100 kHz Above 1 GHz: 1 MHz
Span:	100 MHz Steps
Trace-Mode:	Max Hold

Limits:

FCC
Spurious Emissions Radiated
Attenuation ≥ 43 + 10log(P) (P, Power in Watts)
-13 dBm

Results:

Radiated emissions measurements were made only at the upper, center, and lower carrier frequencies of the LTE band 17 (706.5 MHz, 710.0 MHz and 713.5 MHz). It was decided that measurements at these three carrier frequencies would be sufficient to demonstrate compliance with emissions limits because it was seen that all the significant spurs occur well outside the band and no radiation was seen from a carrier in one block of the LTE band 17 into any of the other blocks. The equipment must still, however, meet emissions requirements with the carrier at all frequencies over which it is capable of operating and it is the manufacturer's responsibility to verify this.

The final open field radiated levels are presented on the next pages.
All measurements were done in horizontal and vertical polarization; the plots show the worst case.
The plots show only the middle channel with 10 MHz bandwidth and full resource blocks. If spurious were detected, the lowest and highest channel and all supported channel bandwidths were checked, too.

As can be seen from this data, the emissions from the test item were within the specification limit.

QPSK

Spurious Emission Level (dBm)					
Lowest channel		**Middle channel**		**Highest channel**	
Spurious emissions	Level [dBm]	Spurious emissions	Level [dBm]	Spurious emissions	Level [dBm]
All detected emissions are more than 20 dB below the limit!					
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
Measurement uncertainty		± 3dB			

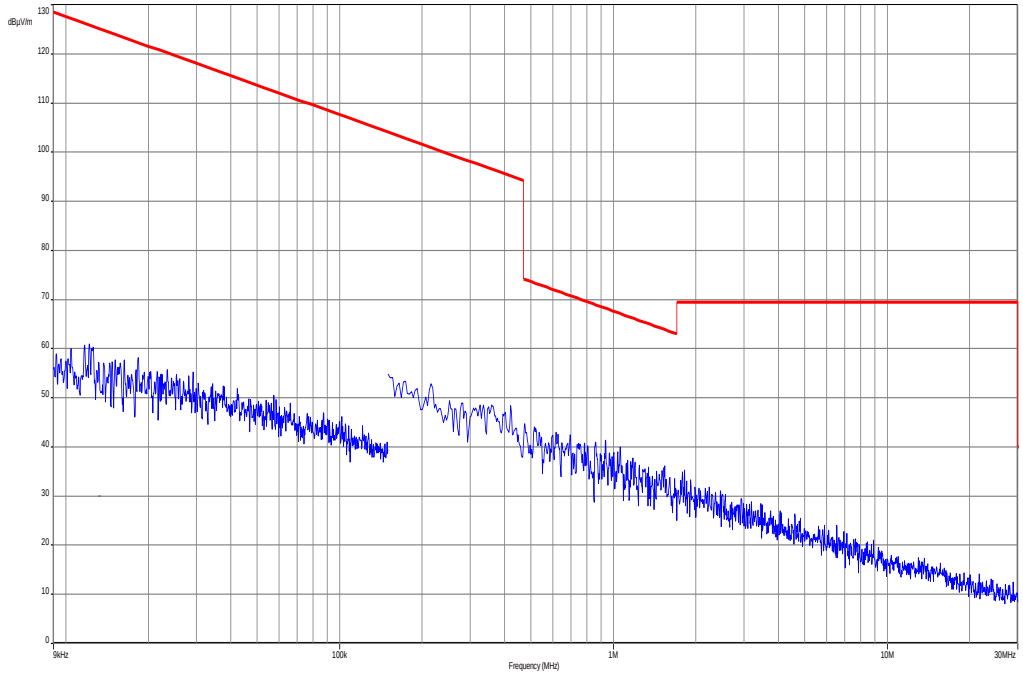
16-QAM

Spurious Emission Level (dBm)					
Lowest channel		**Middle channel**		**Highest channel**	
Spurious emissions	Level [dBm]	Spurious emissions	Level [dBm]	Spurious emissions	Level [dBm]
All detected emissions are more than 20 dB below the limit!					
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
Measurement uncertainty		± 3dB			

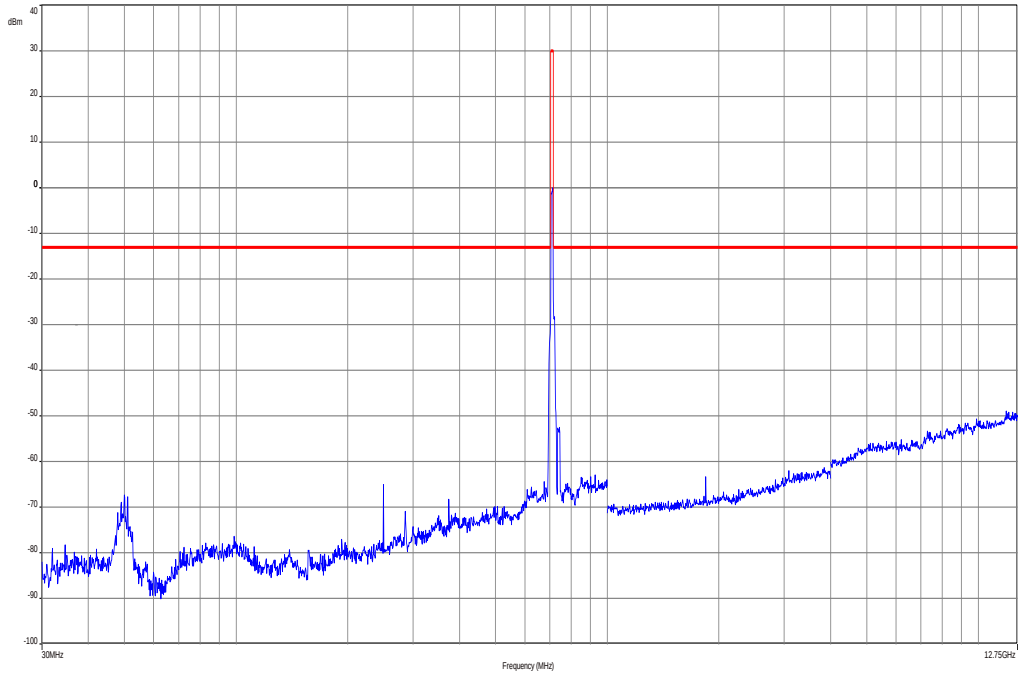
Result: **Passed**

QPSK with 10 MHz channel bandwidth

Plot 1: Middle channel, up to 30 MHz

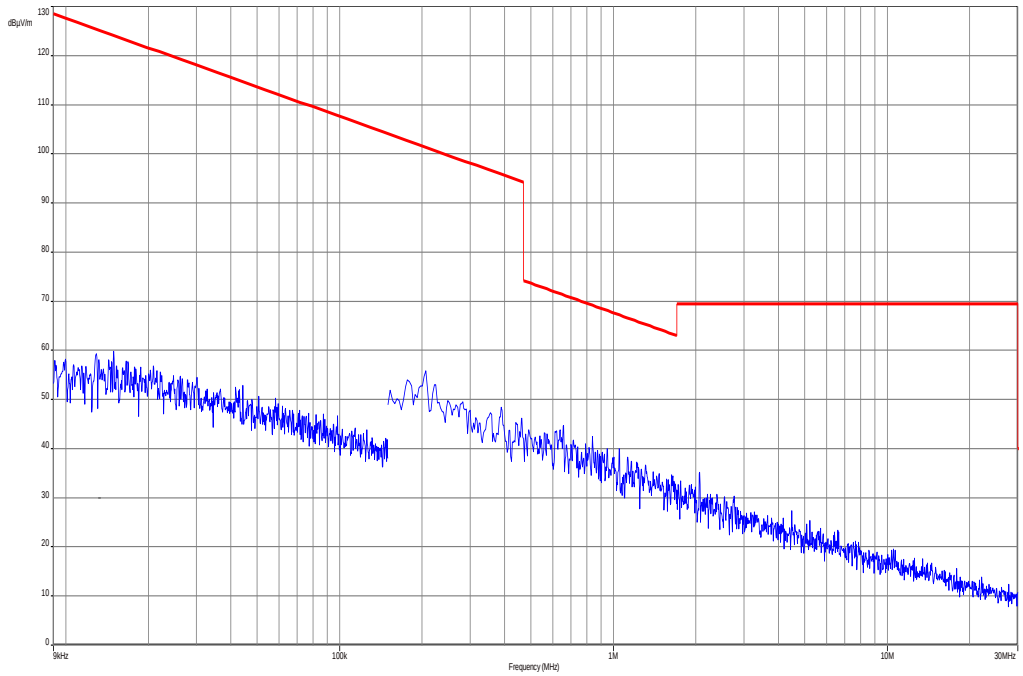


Plot 2: Middle channel, 30 MHz to 12.75 GHz

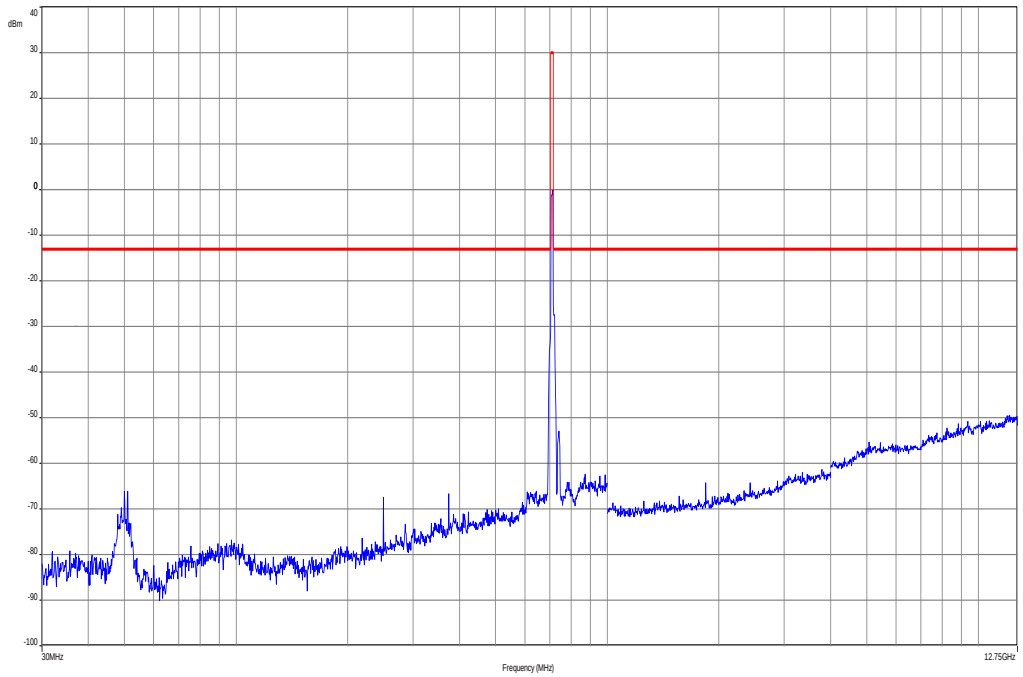


16-QAM with 10 MHz channel bandwidth

Plot 5: Middle channel, up to 30 MHz



Plot 6: Middle channel, 30 MHz to 12.75 GHz



8.3.4 Spurious emissions conducted

Description:

The following steps outline the procedure used to measure the conducted emissions from the mobile station.
1. Determine frequency range for measurements: From CFR 2.1057 the spectrum should be investigated from the lowest radio frequency generated in the equipment up to at least the 10th harmonic of the carrier frequency. For the mobile station equipment tested, this equates to a frequency range of 13 MHz to 7460 MHz, data taken from 10 MHz to 25 GHz.
2. Determine mobile station transmits frequencies: below outlines the band edge frequencies pertinent to conducted emissions testing.

Measurement:

Measurement parameters	
Detector:	Peak
Sweep time:	Auto
Video bandwidth:	Pre-measurement with 1 MHz On spurious detection re-measurement below 1 GHz with 100 kHz Above 1 GHz with 1 MHz
Resolution bandwidth:	Pre-measurement with 1 MHz On spurious detection re-measurement below 1 GHz with 100 kHz Above 1 GHz with 1 MHz
Span:	10 MHz – 26 GHz
Trace-Mode:	Max Hold

Limits:

FCC
Spurious Emissions Conducted
Attenuation ≥ 43 + 10log(P) (P, Power in Watts)
-13 dBm

Results: **for 5 MHz channel bandwidth**

QPSK

Spurious Emission Level (dBm)					
Lowest channel		**Middle channel**		**Highest channel**	
Spurious emissions	Level [dBm]	Spurious emissions	Level [dBm]	Spurious emissions	Level [dBm]
No emissions detected.		No emissions detected.		No emissions detected.	
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
Measurement uncertainty		± 3dB			

16-QAM

Spurious Emission Level (dBm)					
Lowest channel		**Middle channel**		**Highest channel**	
Spurious emissions	Level [dBm]	Spurious emissions	Level [dBm]	Spurious emissions	Level [dBm]
No emissions detected.		No emissions detected.		No emissions detected.	
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
Measurement uncertainty		± 3dB			

Result: **Passed**

Results: **for 10 MHz channel bandwidth**

QPSK

Spurious Emission Level (dBm)					
Lowest channel		**Middle channel**		**Highest channel**	
Spurious emissions	Level [dBm]	Spurious emissions	Level [dBm]	Spurious emissions	Level [dBm]
No emissions detected.		No emissions detected.		No emissions detected.	
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
Measurement uncertainty		± 3dB			

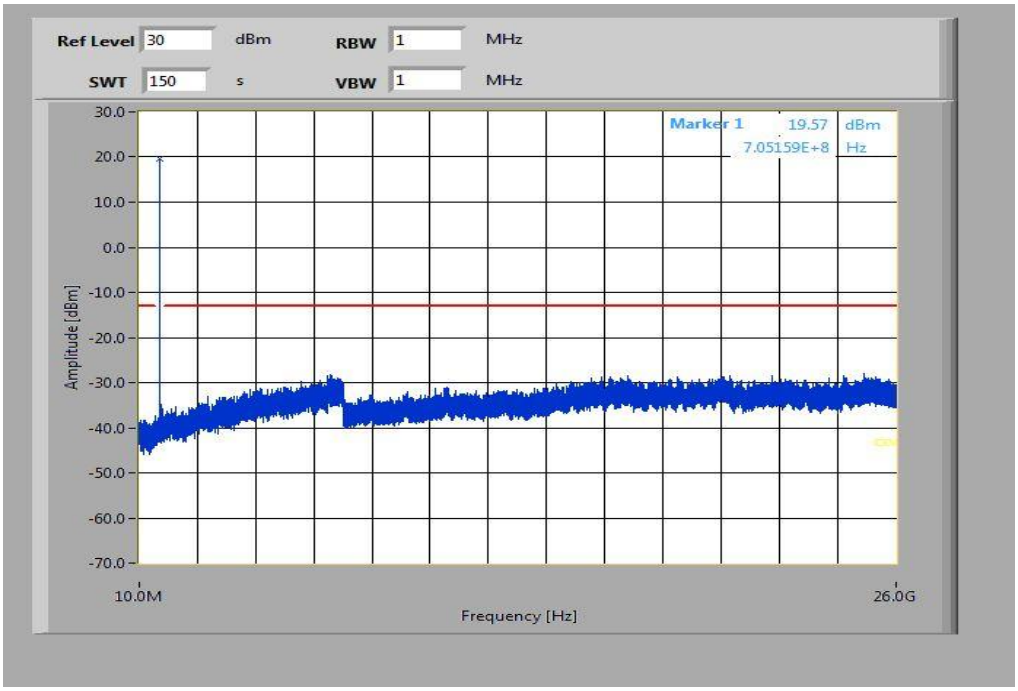
16-QAM

Spurious Emission Level (dBm)					
Lowest channel		**Middle channel**		**Highest channel**	
Spurious emissions	Level [dBm]	Spurious emissions	Level [dBm]	Spurious emissions	Level [dBm]
No emissions detected.		No emissions detected.		No emissions detected.	
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
	-		-		-
Measurement uncertainty		± 3dB			

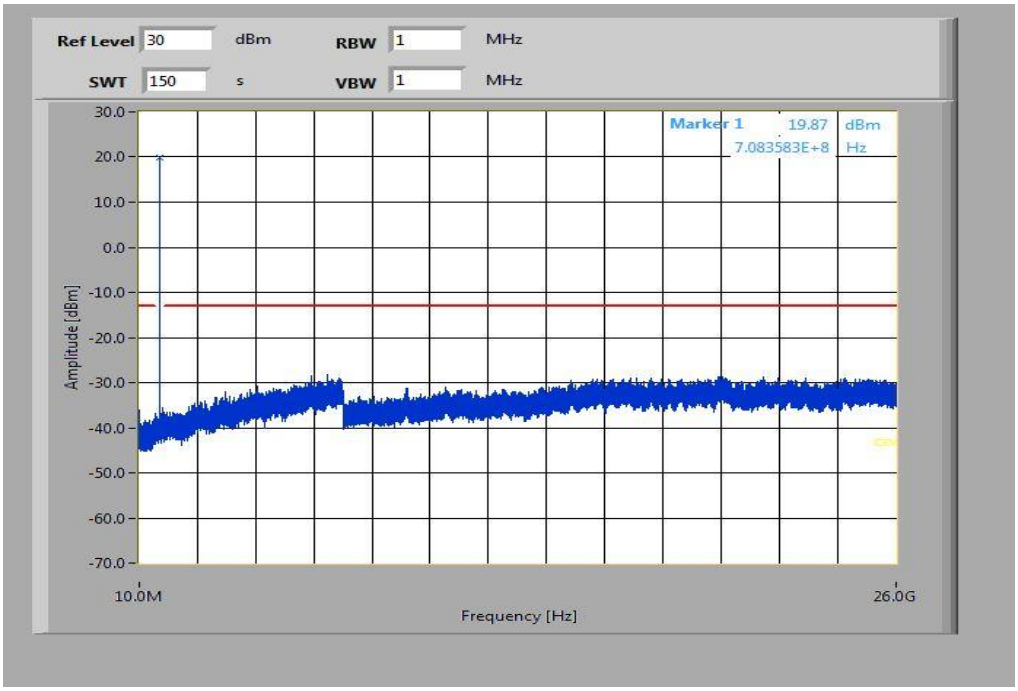
Result: **Passed**

Plots for 5 MHz channel bandwidth, QPSK

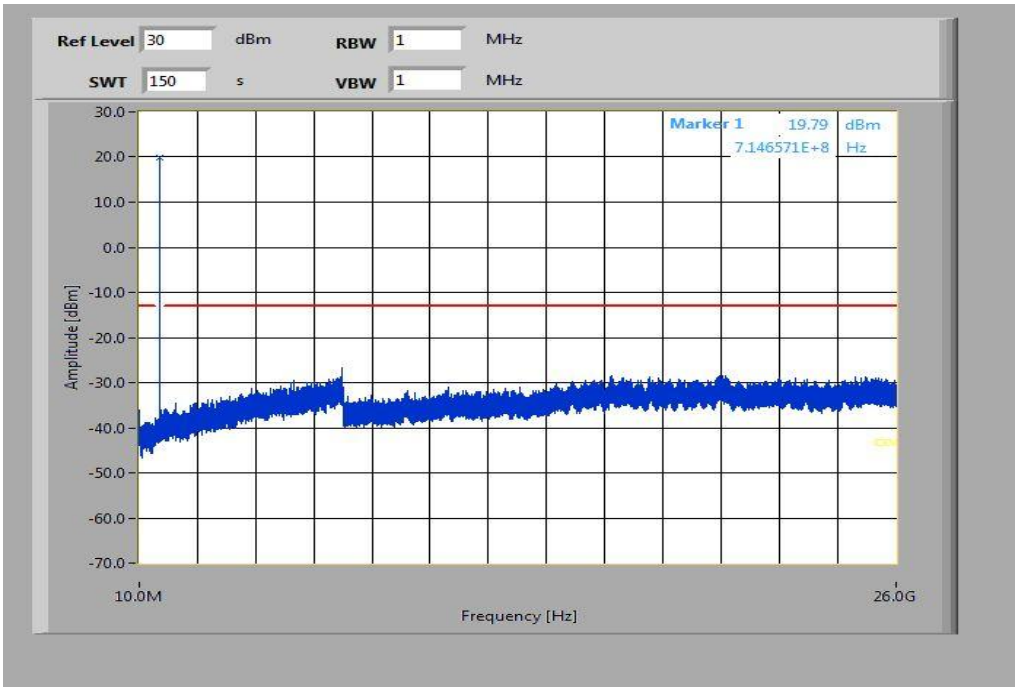
Plot 1: Lowest channel, 10 MHz to 26 GHz



Plot 2: Middle channel, 10 MHz to 26 GHz

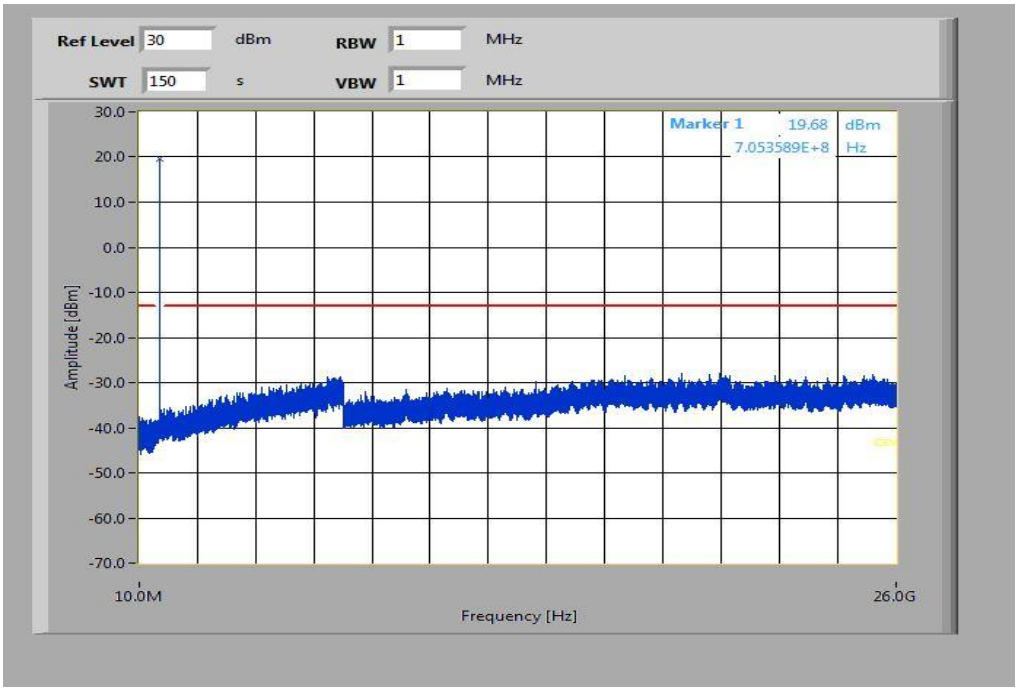


Plot 3: Highest channel, 10 MHz to 26 GHz

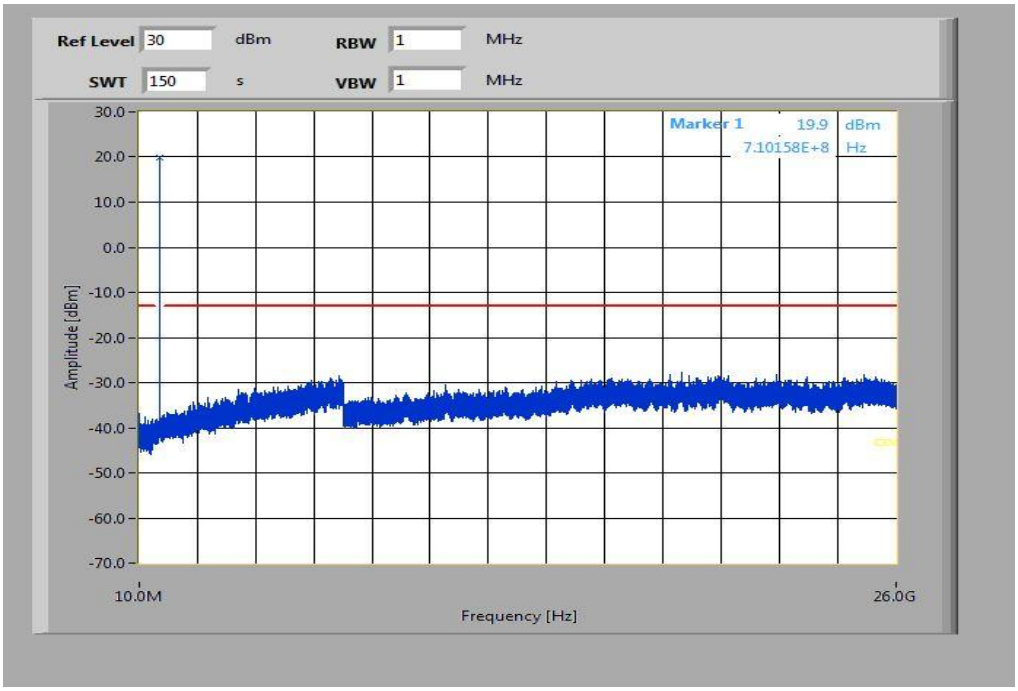


Plots for 5 MHz channel bandwidth, 16-QAM

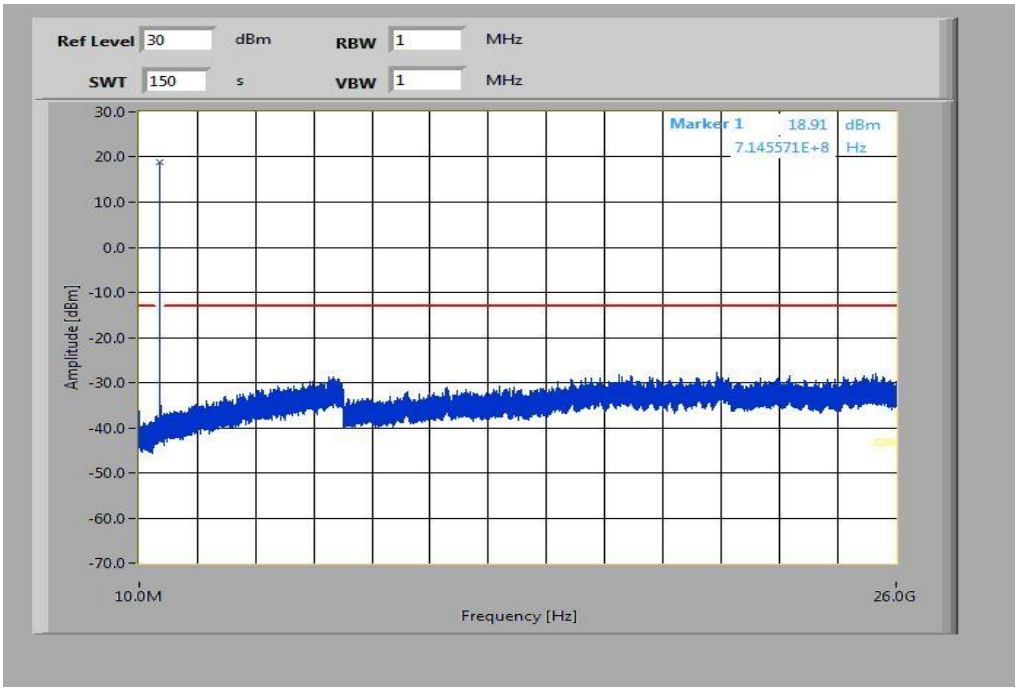
Plot 4: Lowest channel, 10 MHz to 26 GHz



Plot 5: Middle channel, 10 MHz to 26 GHz

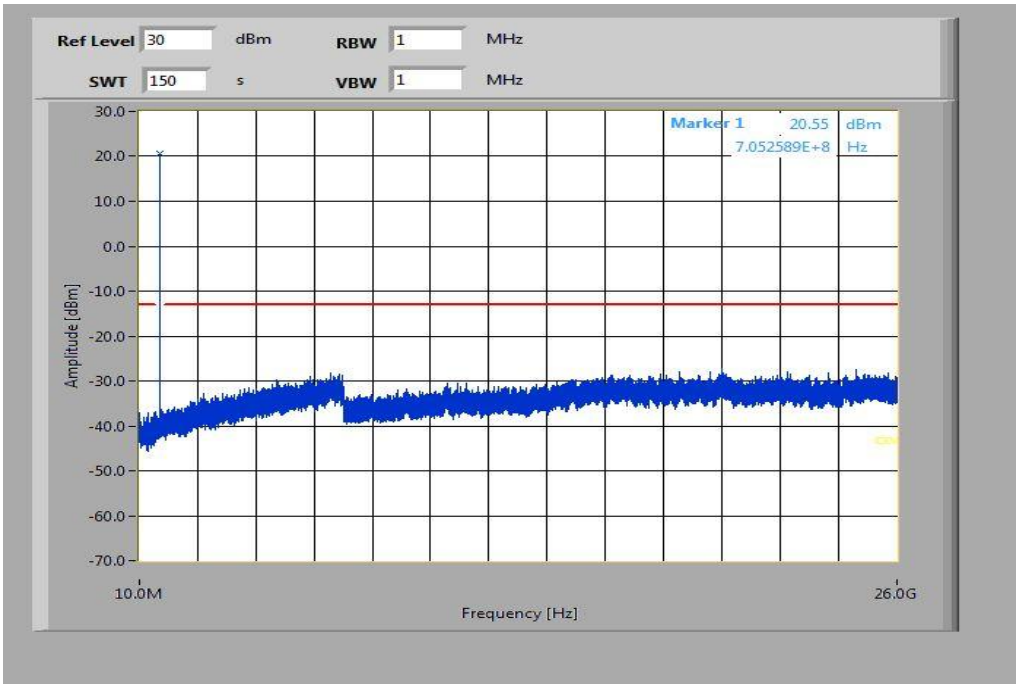


Plot 6: Highest channel, 10 MHz to 26 GHz

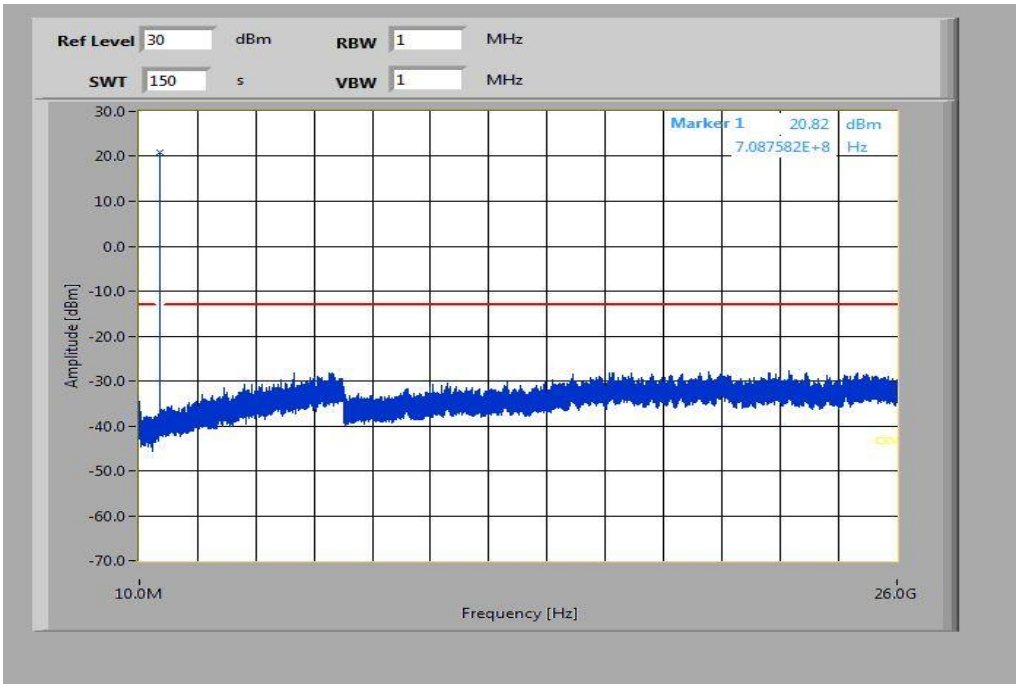


Plots for 10 MHz channel bandwidth, QPSK

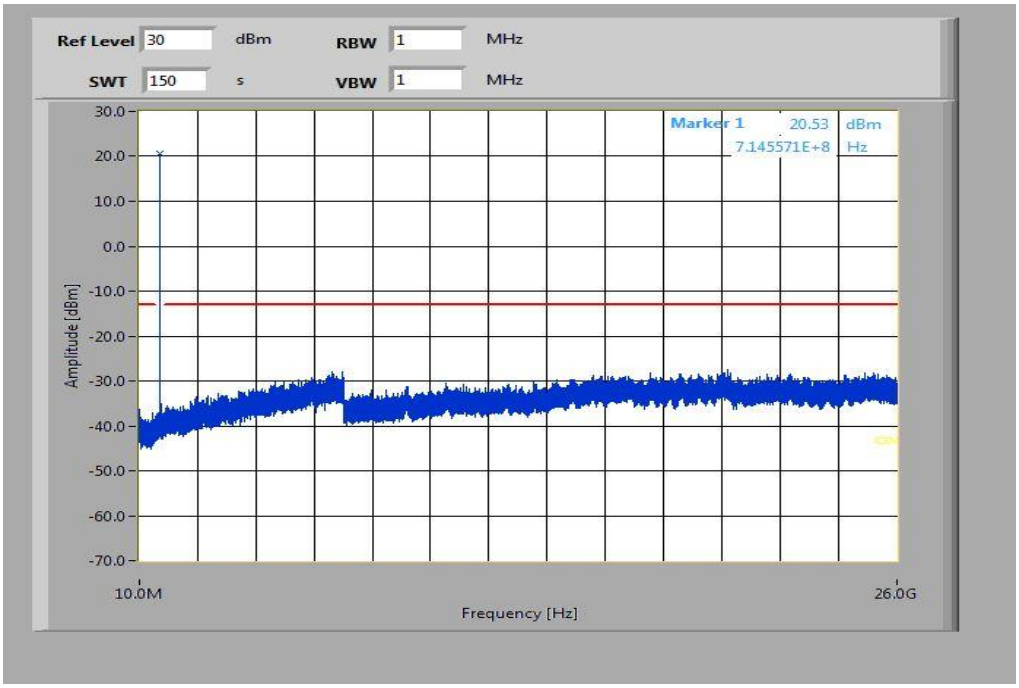
Plot 1: Lowest channel, 10 MHz to 26 GHz



Plot 2: Middle channel, 10 MHz to 26 GHz

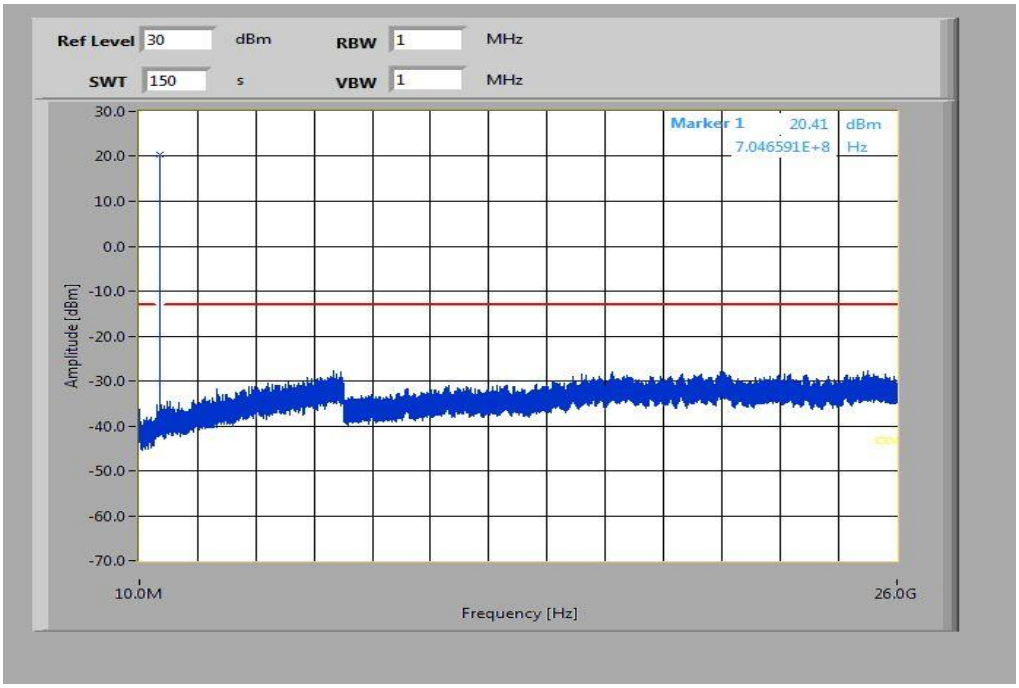


Plot 3: Highest channel, 10 MHz to 26 GHz

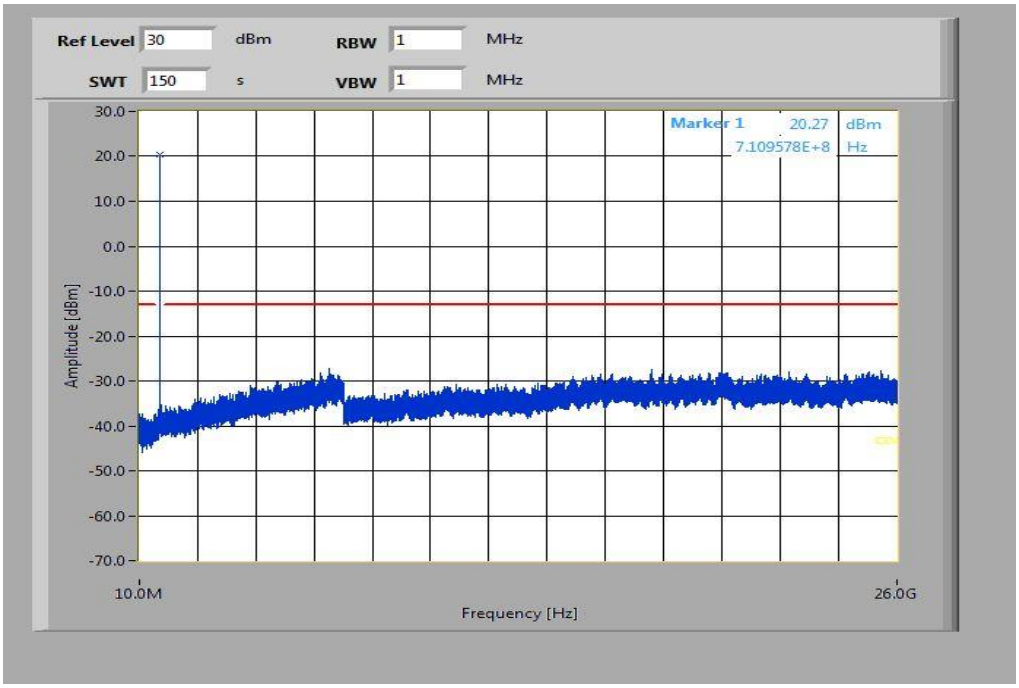


Plots for 10 MHz channel bandwidth, 16-QAM

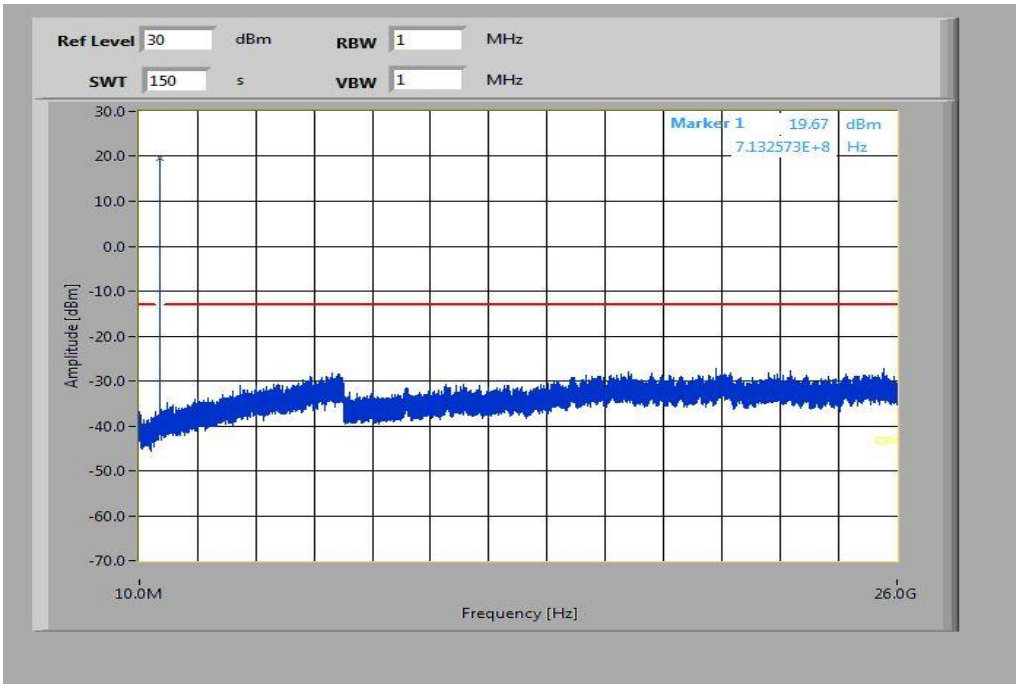
Plot 4: Lowest channel, 10 MHz to 26 GHz



Plot 5: Middle channel, 10 MHz to 26 GHz



Plot 6: Highest channel, 10 MHz to 26 GHz



8.3.5 Block edge compliance

Description:

The spectrum at the band edges must comply with the spurious emissions limits.

Measurement:

Measurement parameters	
Detector:	RMS
Sweep time:	20 sec.
Video bandwidth:	30 kHz
Resolution bandwidth:	30 kHz
Span:	1 MHz
Trace-Mode:	Max Hold

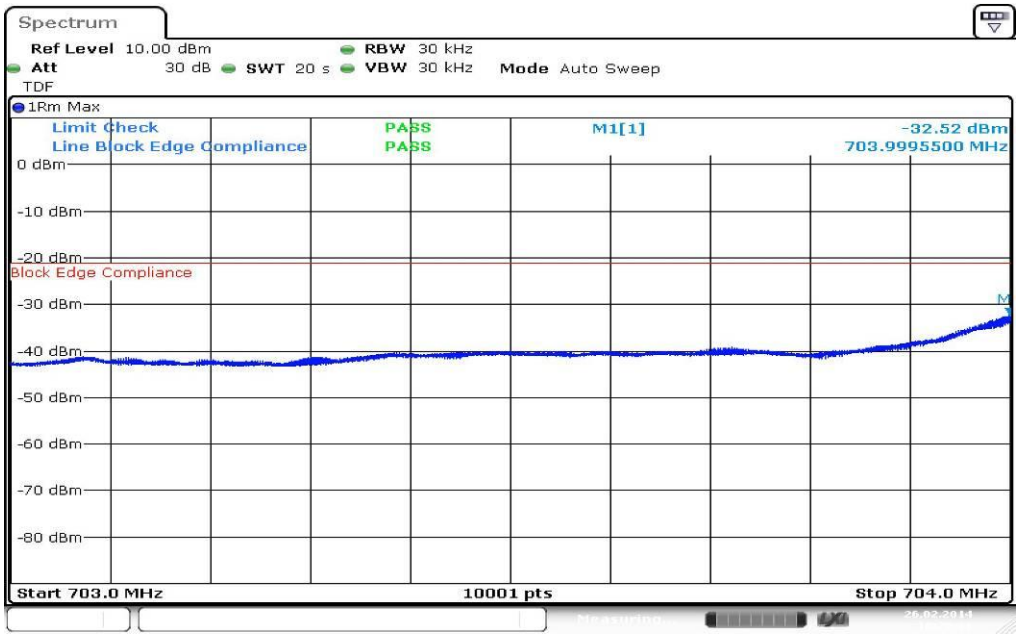
Limits:

FCC
Block Edge Compliance
Part 27.53 specifies that “the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB.” However, in publication number 890810, The FCC Office of Engineering and Technology specified the following correction to the limits when a resolution bandwidth smaller than 1% of the emission bandwidth is used: “An alternative is to add an additional correction factor of 10 Log (RBW1/ RBW2) to the 43 +10 log(P) limit. RBW1 is the narrower measurement resolution bandwidth and RBW2 is either the 1% emissions bandwidth or 1 MHz.” When using a 30 kHz bandwidth, this yields a -5.2288 adjustment to the limit [10 log(30kHz/100kHz) = -5.2288]. When this adjustment is applied to the limit, the limit becomes -18.2288.
-18.23 dBm

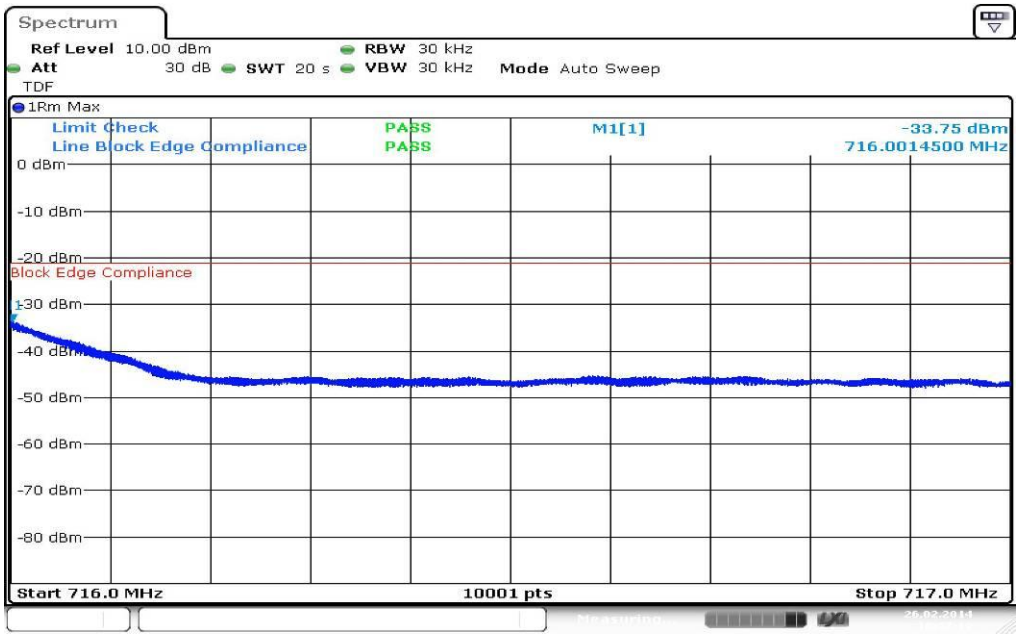
The limit line in the plots is the overall LTE bands and channel bandwidths worst case -21.24 dBm.

Results: **5 MHz channel bandwidth**

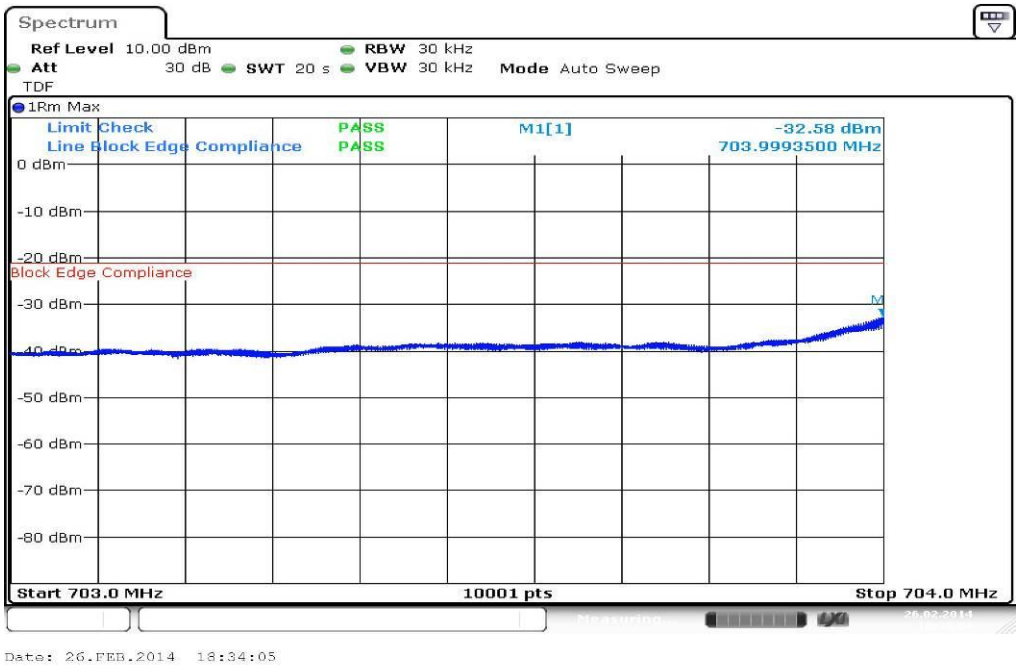
Plot 1: Lowest channel, QPSK modulation



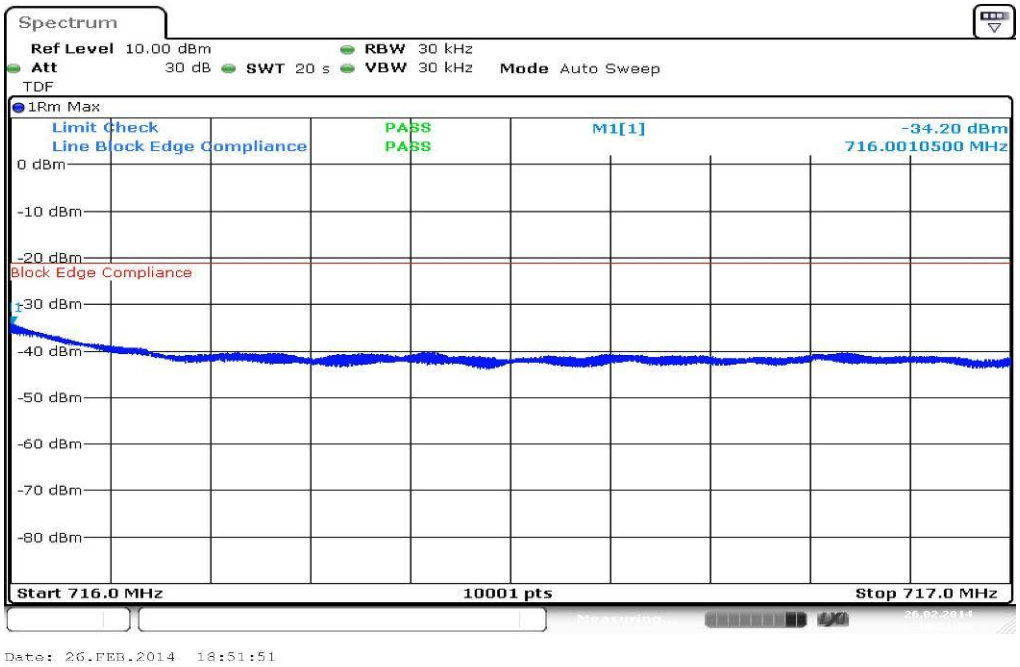
Plot 2: Highest channel, QPSK modulation



Plot 3: Lowest channel, 16 – QAM modulation

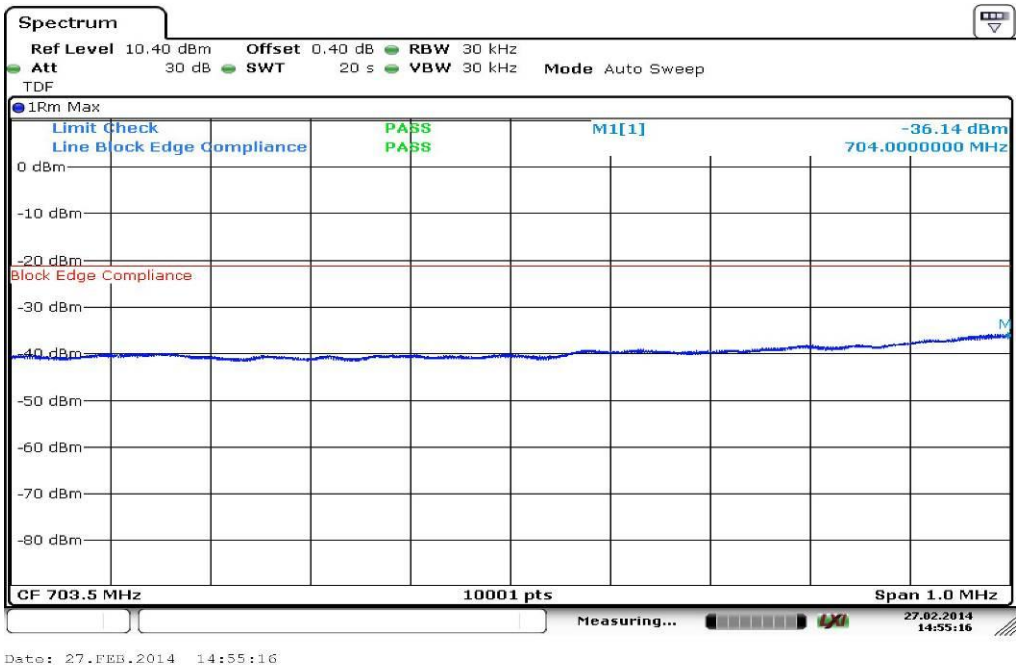


Plot 4: Highest channel, 16 – QAM modulation



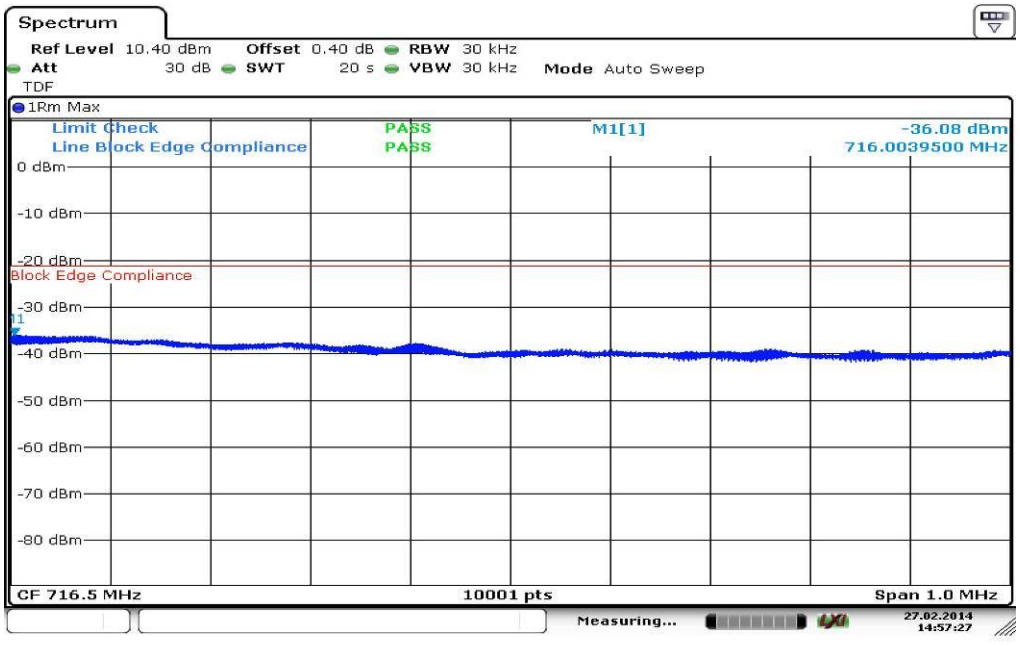
Results: **10 MHz channel bandwidth**

Plot 1: Lowest channel, QPSK modulation



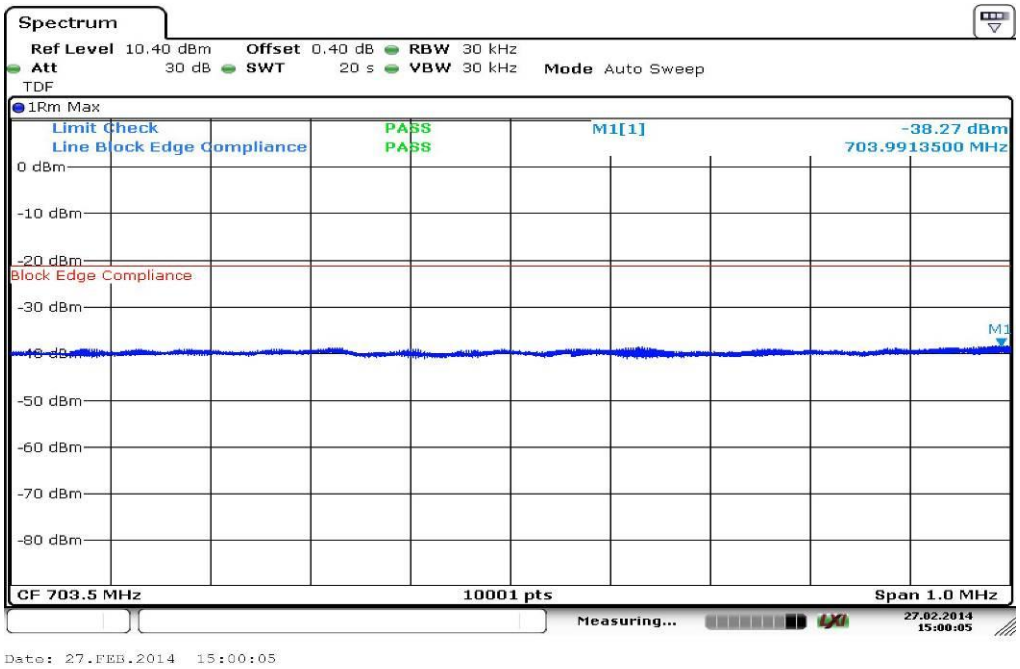
Date: 27.FEB.2014 14:55:16

Plot 2: Highest channel, QPSK modulation

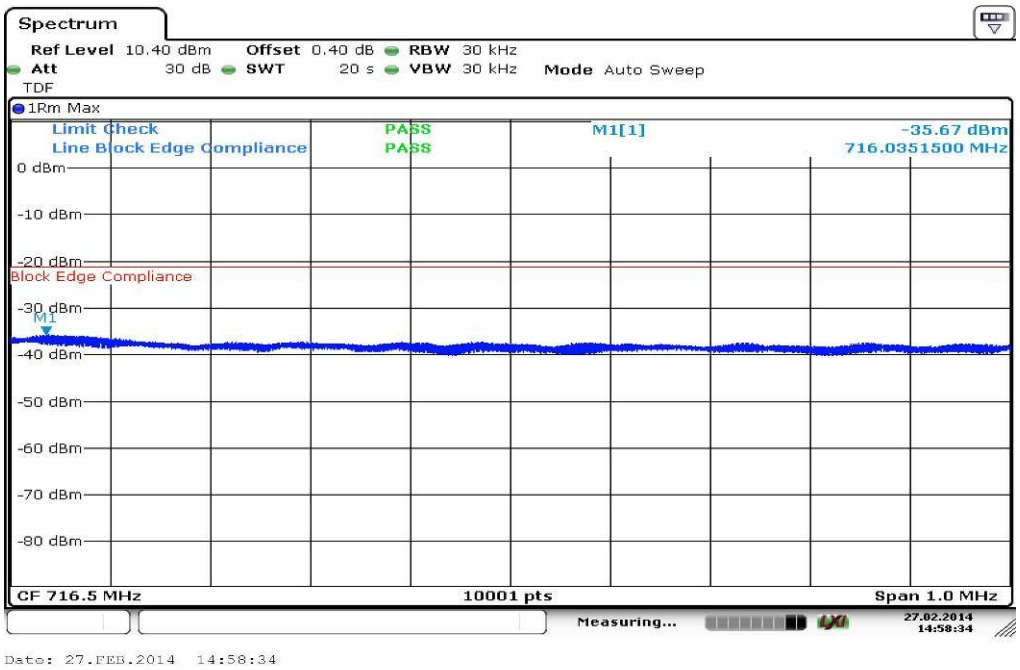


Date: 27.FEB.2014 14:57:26

Plot 3: Lowest channel, 16 – QAM modulation



Plot 4: Highest channel, 16 – QAM modulation



Result: **Passed**

8.3.6 Occupied bandwidth

Description:

Measurement of the occupied bandwidth of the transmitted signal.

Measurement:

Similar to conducted emissions, occupied bandwidth measurements are only provided for selected frequencies in order to reduce the amount of submitted data. Data were taken at the mid frequencies of the LTE band 17. The table below lists the measured 99% power bandwidths. Spectrum analyzer plots are included on the following pages.

Part 27.53 requires a measurement bandwidth of at least 1% of the occupied bandwidth.

Measurement parameters	
Detector:	Peak
Sweep time:	Auto
Video bandwidth:	Depends on Channel Bandwidth
Resolution bandwidth:	Depends on Channel Bandwidth
Span:	Depends on Channel Bandwidth
Trace-Mode:	Max Hold

Limits:

FCC
Occupied Bandwidth
Spectrum must fall completely in the specified band

Results:

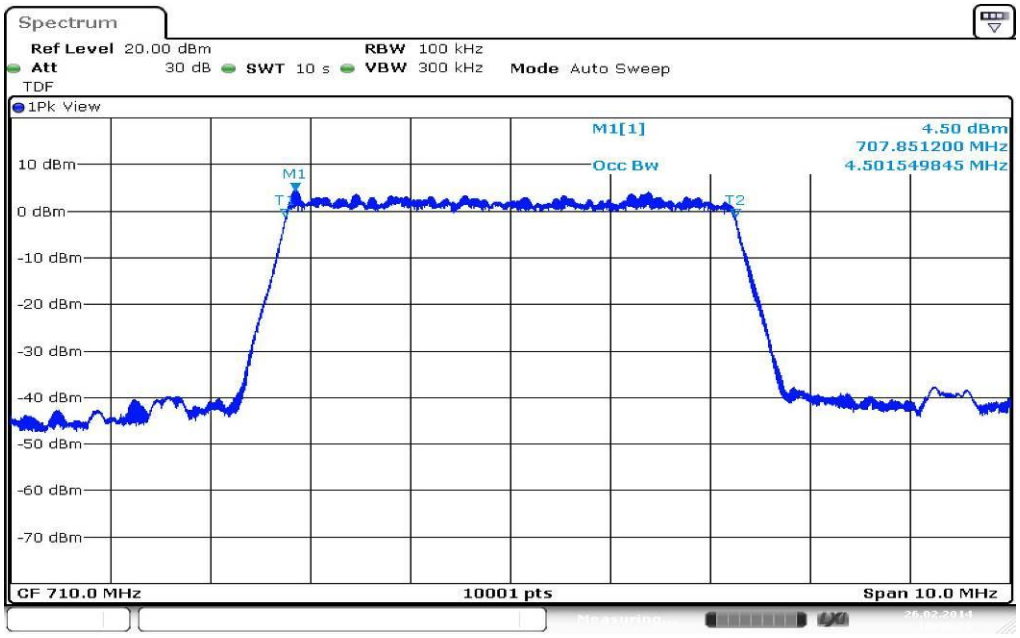
Occupied Bandwidth - QPSK		
Bandwidth [MHz]	**99% OBW (kHz)**	**-26 dBc BW (kHz)**
5	4502	4993
10	8921	9841
Measurement uncertainty	± 100 kHz	

Occupied Bandwidth – 16-QAM		
Bandwidth [MHz]	**99% OBW (kHz)**	**-26 dBc BW (kHz)**
5	4520	5022
10	8921	9783
Measurement uncertainty	± 100 kHz	

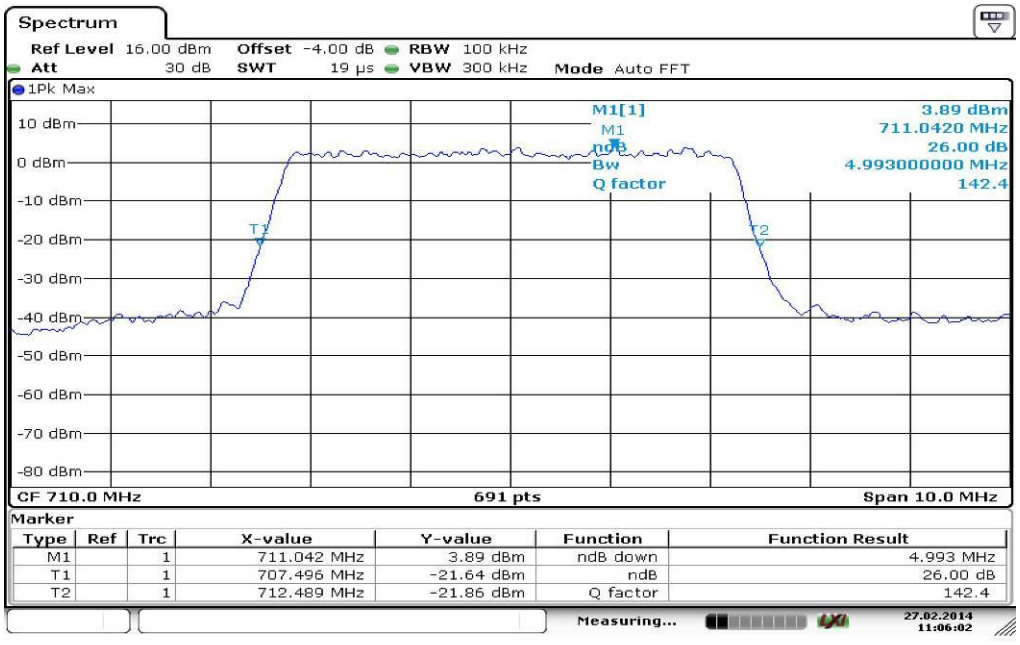
Result: **Passed**

Plots: QPSK

Plot 1: 5 MHz, 99% OBW

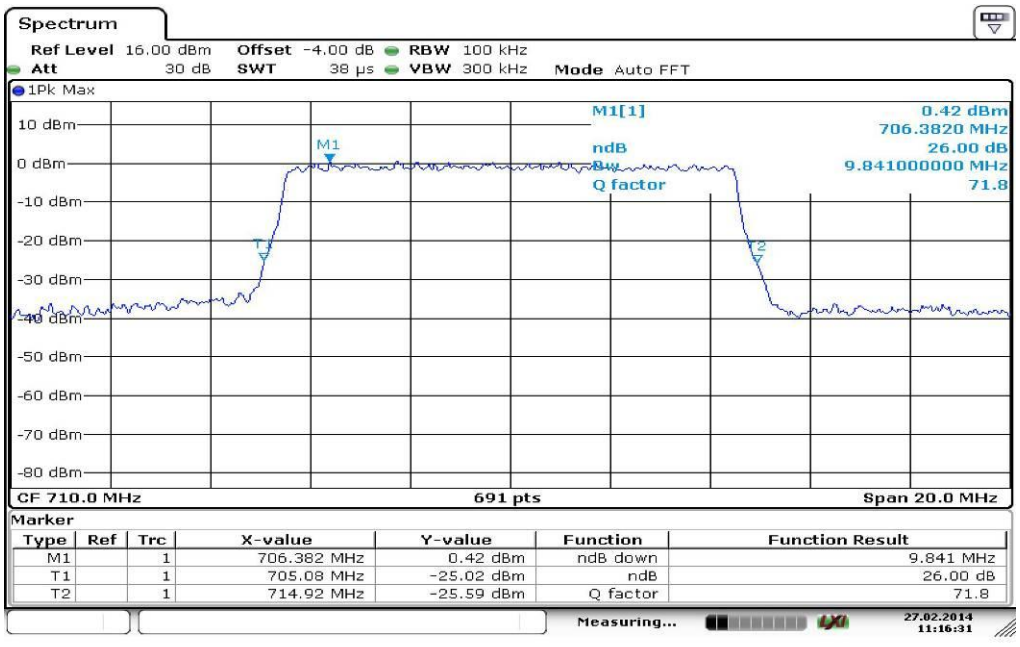


Plot 2: 5 MHz, -26 dBc OBW



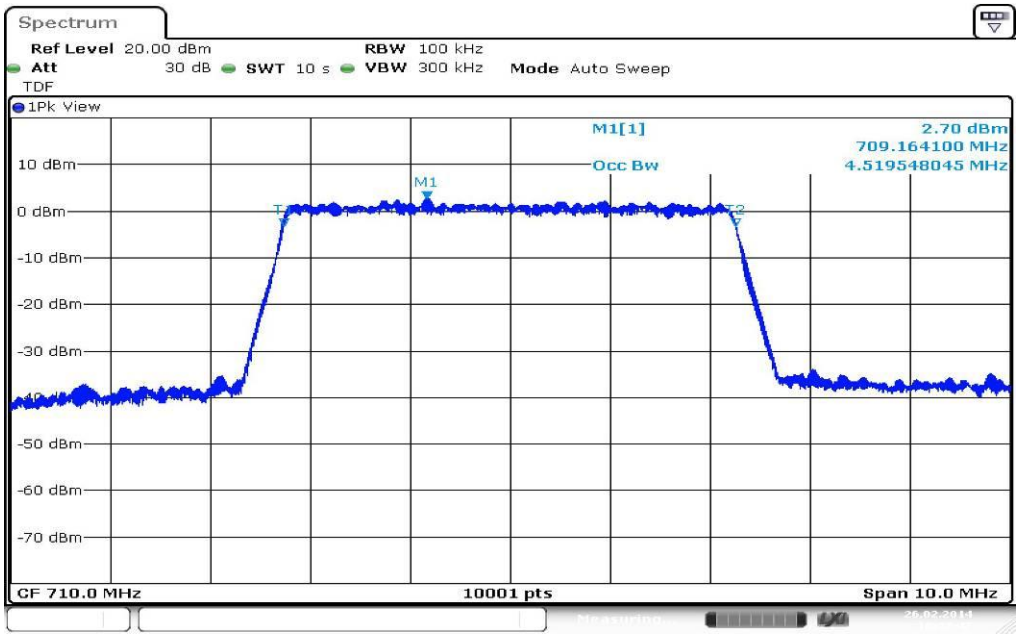
Plot 3: 10 MHz, 99% OBW

Plot 4: 10 MHz, -26 dBc OBW

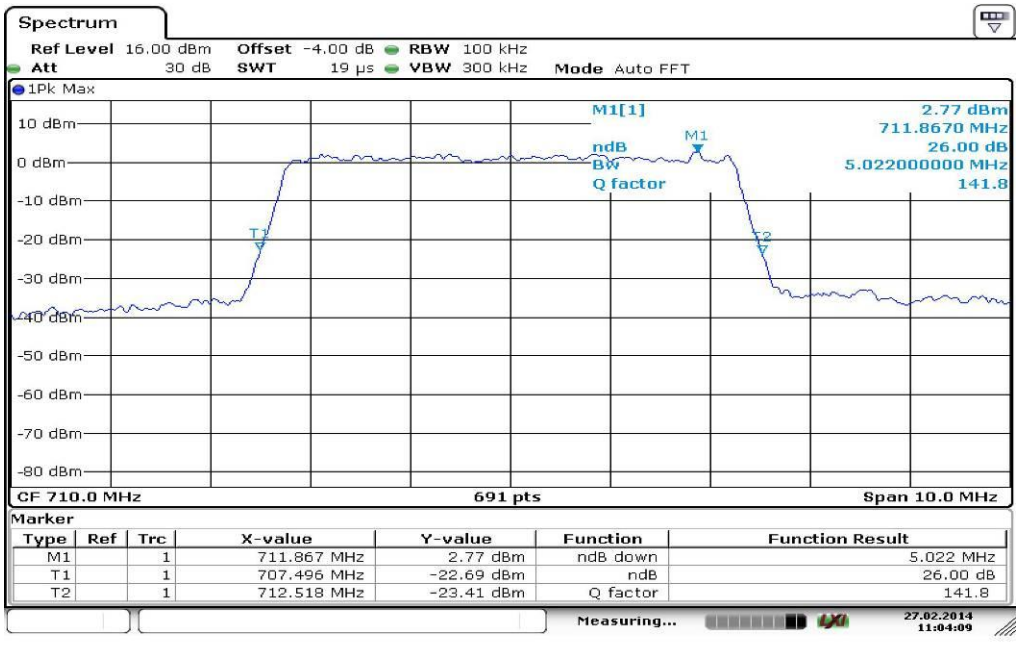


Plots: 16-QAM

Plot 1: 5 MHz, 99% OBW

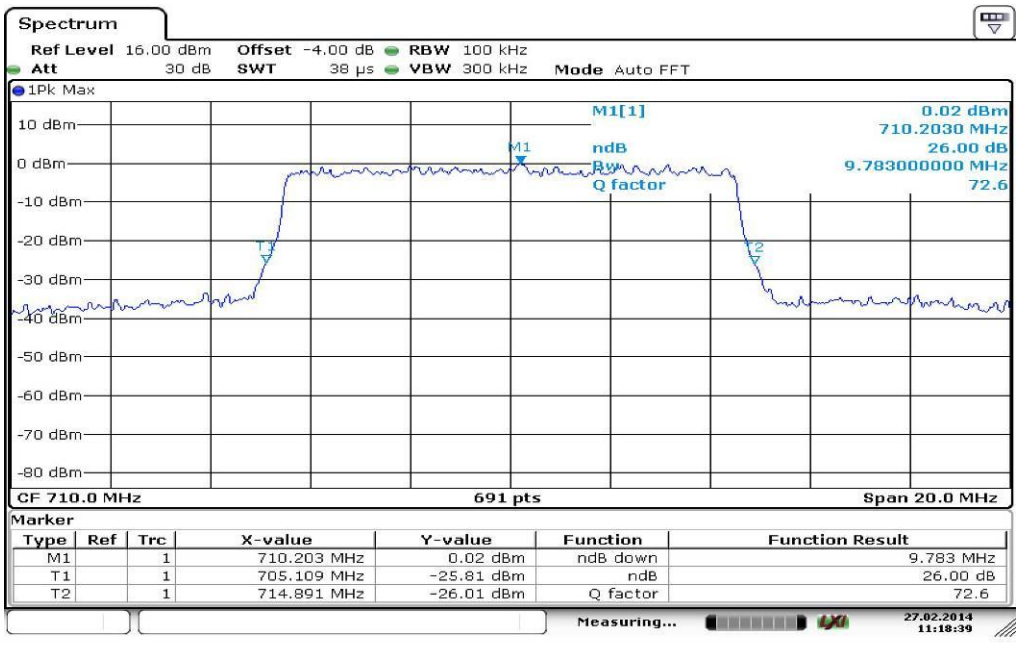


Plot 2: 5 MHz, -26 dBc OBW



Plot 3: 10 MHz, 99% OBW

Plot 4: 10 MHz, -26 dBc OBW



9 Test equipment and ancillaries used for tests

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, rf-generating and signalling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Lab/Item).

No.	Lab / Item	Equipment	Type	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	n. a.	Double-Ridged Waveguide Horn Antenna 1-18.0GHz	3115	EMCO	8812-3088	300001032	vlKl!	08.05.2013	08.05.2015
2	n. a.	Anechoic chamber	FAC 3/5m	MWB / TDK	87400/02	300000996	ev		
3	n. a.	Switch / Control Unit	3488A	HP Meßtechnik	*	300000199	ne		
4	n. a.	Three-Way Power Splitter, 50 Ohm	11850C	HP Meßtechnik		300000997	ne		
5	n. a.	Amplifier	js42-00502650-28-5a	Parzich GMBH	928979	300003143	ne		
6	n. a.	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	371	300003854	vlKl!	14.10.2011	14.10.2014
7	n. a.	MXE EMI Receiver 20 Hz bis 26,5 GHz	N9038A	Agilent Technologies	MY51210197	300004405	k	21.02.2013	21.02.2015
8	11b	Microwave System Amplifier, 0.5-26.5 GHz	83017A	HP Meßtechnik	00419	300002268	ev		
9	A026	Std. Gain Horn Antenna 12.4 to 18.0 GHz	639	Narda	8402	300000787	k	22.07.2013	22.07.2015
10	A029	Std. Gain Horn Antenna 18.0 to 26.5 GHz	638	Narda	8205	300002442	k	19.07.2013	19.07.2015
11	n. a.	Signal Analyzer 40 GHz	FSV40	R&S	101042	300004517	k	21.01.2014	21.01.2015
12	n. a.	Temperature Test Chamber	VT 4002	Heraeus Voetsch	521/84193	300003889	Ve	26.09.2013	26.09.2015
13	n. a.	Power Supply 0-20V, 0-5A	6632B	Agilent Technologies	GB42110541	400000562	vlKl!	10.01.2013	10.01.2016

Agenda: Kind of Calibration

k	calibration / calibrated
ne	not required (k, ev, izw, zw not required)
ev	periodic self verification
Ve	long-term stability recognized
vlkl!	Attention: extended calibration interval
NK!	Attention: not calibrated
EK	limited calibration
zw	cyclical maintenance (external cyclical maintenance)
izw	internal cyclical maintenance
g	blocked for accredited testing
*)	next calibration ordered / currently in progress

10 Observations

No observations exceeding those reported with the single test cases have been made.

Annex A Document history

Version	Applied changes	Date of release
	Initial release	2014-02-28

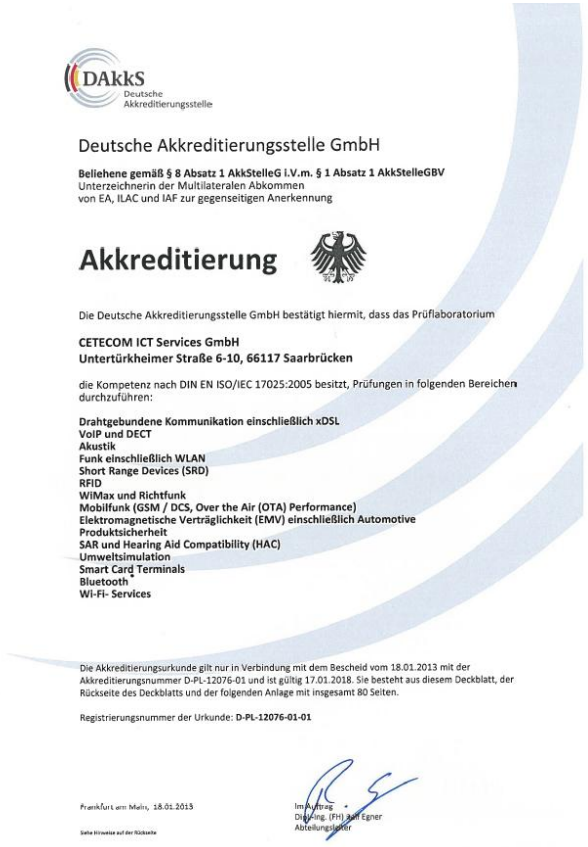
Annex B Further information

Glossary

AVG	-	Average
DUT	-	Device under test
EMC	-	Electromagnetic Compatibility
EN	-	European Standard
EUT	-	Equipment under test
ETSI	-	European Telecommunications Standard Institute
FCC	-	Federal Communication Commission
FCC ID	-	Company Identifier at FCC
HW	-	Hardware
IC	-	Industry Canada
Inv. No.	-	Inventory number
N/A	-	Not applicable
PP	-	Positive peak
QP	-	Quasi peak
S/N	-	Serial number
SW	-	Software

Annex C Accreditation Certificate

Front side of certificate



DAkkS
Deutsche Akkreditierungsstelle

Deutsche Akkreditierungsstelle GmbH

Beliehene gemäß § 8 Absatz 1 AkkStelleG i.V.m. § 1 Absatz 1 AkkStelleGBV
Unterzeichnerin der Multilateralen Abkommen
von EA, ILAC und IAF zur gegenseitigen Anerkennung

Akkreditierung

Die Deutsche Akkreditierungsstelle GmbH bestätigt hiermit, dass das Prüflaboratorium

CETECOM ICT Services GmbH
Untertürkheimer Straße 6-10, 66117 Saarbrücken

die Kompetenz nach DIN EN ISO/IEC 17025:2005 besitzt, Prüfungen in folgenden Bereichen durchzuführen:

Drahtgebundene Kommunikation einschließlich xDSL
VoIP und DECT
Akustik
Funk einschließlich WLAN
Short Range Devices (SRD)
RFID
WiMax und Richtfunk
Mobilfunk (GSM / DCS, Over the Air (OTA) Performance)
Elektromagnetische Verträglichkeit (EMV) einschließlich Automotive
Produktsicherheit
SAR und Hearing Aid Compatibility (HAC)
Umweltsimulation
Smart Card Terminals
Bluetooth
Wi-Fi- Services

Die Akkreditierungsurkunde gilt nur in Verbindung mit dem Bescheid vom 18.01.2013 mit der Akkreditierungsnummer D-PL-12076-01 und ist gültig 17.01.2018. Sie besteht aus diesem Deckblatt, der Rückseite des Deckblatts und der folgenden Anlage mit insgesamt 80 Seiten.

Registrierungsnummer der Urkunde: **D-PL-12076-01-01**

Frankfurt am Main, 18.01.2013

Im Auftrag
Dipl.-Ing. (FH) Arn Egner
Abteilungsleiter

Siehe Hinweise auf der Rückseite

Back side of certificate

Deutsche Akkreditierungsstelle GmbH

Standort Berlin
Spittelmarkt 10
10117 Berlin

Standort Frankfurt am Main
Gartenstraße 6
60594 Frankfurt am Main

Standort Braunschweig
Bundesallee 100
38116 Braunschweig

Die auszugsweise Veröffentlichung der Akkreditierungsurkunde bedarf der vorherigen schriftlichen Zustimmung der Deutsche Akkreditierungsstelle GmbH (DAkkS). Ausgenommen davon ist die separate Weiterverbreitung des Deckblattes durch die umseitig genannte Konformitätsbewertungsstelle in unveränderter Form.

Es darf nicht der Anschein erweckt werden, dass sich die Akkreditierung auch auf Bereiche erstreckt, die über den durch die DAkkS bestätigten Akkreditierungsbereich hinausgehen.

Die Akkreditierung erfolgte gemäß des Gesetzes über die Akkreditierungsstelle (AkkStelleG) vom 31. Juli 2009 (BGBl. I S. 2625) sowie der Verordnung (EG) Nr. 765/2008 des Europäischen Parlaments und des Rates vom 9. Juli 2008 über die Vorschriften für die Akkreditierung und Marktüberwachung im Zusammenhang mit der Vermarktung von Produkten (Abl. L 218 vom 9. Juli 2008, S. 30).
Die DAkkS ist Unterzeichnerin der Multilateralen Abkommen zur gegenseitigen Anerkennung der European co-operation for Accreditation (EA), des International Accreditation Forum (IAF) und der International Laboratory Accreditation Cooperation (ILAC). Die Unterzeichner dieser Abkommen erkennen ihre Akkreditierungen gegenseitig an.

Der aktuelle Stand der Mitgliedschaft kann folgenden Webseiten entnommen werden:
EA: www.european-accreditation.org
ILAC: www.ilac.org
IAF: www.iaf.nu

Note:

The current certificate including annex is published on our website (see link below) or may be received from CETECOM ICT Services on request.

http://www.cetecom.com/eu/de/cetecom-group/europa/deutschland-saarbruecken/akkreditierungen.html